

MOTOROLA
SEMICONDUCTOR
TECHNICAL DATA

MOTOROLA SC XSTRS/R F

MRF2005M

The RF Line

NPN SILICON MICROWAVE POWER TRANSISTOR

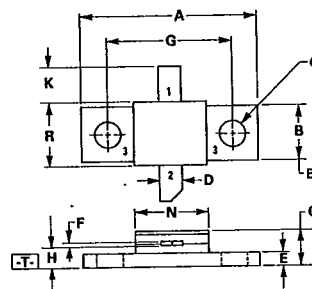
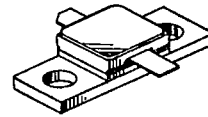
... designed for Class B and C *common base* broadband amplifier applications in the 1.7 to 2.3 GHz frequency range.

- Internal Input Matching for Broadband Operation
- Guaranteed Performance @ 2 GHz, 24 Vdc
Output power = 5.0 Watts
Minimum Gain = 7.5 dB
- 100% Tested for Load Mismatch at All Phase Angles with 10:1 VSWR
- Hermetically Sealed Industry Standard Package
- Gold Metallized, Emitter Ballasted for Long Life and Resistance to Metal Migration
- Silicon Nitride Passivation
- Characterized for Operation from 20 V to 28 V Supply Voltages

5.0 W 2 GHz

MICROWAVE POWER TRANSISTOR

NPN SILICON



STYLE 1:
PIN 1. EMITTER
2. COLLECTOR
3. BASE

- NOTES:
1. DIMENSIONS [A] AND [B] ARE DATUMS
 2. POSITIONAL TOLERANCE FOR MOUNTING HOLES:
Ⓢ 0.13 (0.005) Ⓢ T A Ⓢ B Ⓢ
 3. [T] IS SEATING PLANE.
 4. DIMENSIONING AND TOLERANCING PER ANSI Y14.5, 1973.

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V _{CEO}	20	Vdc
Collector-Base Voltage	V _{CBO}	45	Vdc
Emitter-Base Voltage	V _{EBO}	3.5	Vdc
Collector-Current — Continuous	I _C	1.0	A dc
Total Device Dissipation @ T _C = 25°C (1) Derate above 25°C	P _D	22 130	Watts mW/°C
Storage Temperature Range	T _{stg}	-65 to +200	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case (2)	R _{θJC}	8.0	°C/W

- (1) This device is designed for RF operation. The total device dissipation rating applies only when the device is operated as an RF amplifier.
(2) Thermal Resistance is determined under specified RF operating conditions by infrared measurement techniques.

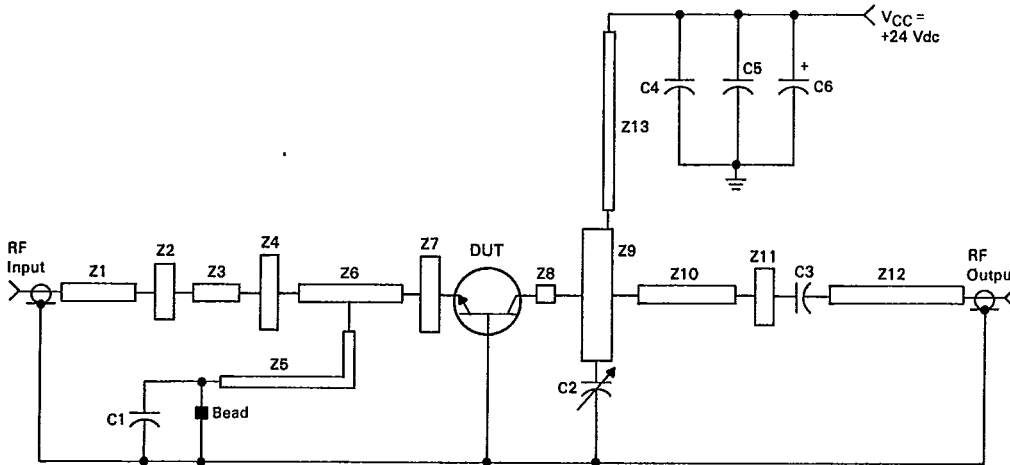
DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	20.07	20.57	0.790	0.810
B	6.48	6.73	0.255	0.265
C	3.68	4.06	0.145	0.160
D	2.29	2.79	0.090	0.110
E	1.42	1.23	0.056	0.068
F	0.05	0.15	0.002	0.006
G	14.27 BSC		0.560 BSC	
H	2.29	2.79	0.090	0.110
K	3.43	4.19	0.135	0.165
N	7.87	8.38	0.310	0.330
Q	3.05	3.30	0.120	0.130
R	7.24	7.49	0.285	0.295

CASE 337-02

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Collector-Emitter Breakdown Voltage (I _C = 10 mA _{dc} , I _B = 0)	V _{(BR)CEO}	20	—	—	V _{dc}
Collector-Emitter Breakdown Voltage (I _C = 10 mA _{dc} , V _{BE} = 0)	V _{(BR)CES}	45	—	—	V _{dc}
Collector-Base Breakdown Voltage (I _C = 10 mA _{dc} , I _E = 0)	V _{(BR)CBO}	45	—	—	V _{dc}
Emitter-Base Breakdown Voltage (I _E = 2.0 mA _{dc} , I _C = 0)	V _{(BR)EBO}	3.5	—	—	V _{dc}
Collector Cutoff Current (V _{CB} = 28 V _{dc} , I _E = 0)	I _{CBO}	—	—	1.0	mA _{dc}
ON CHARACTERISTICS					
DC Current Gain (I _C = 300 mA _{dc} , V _{CE} = 5.0 V _{dc})	h _{FE}	10	—	100	—
DYNAMIC CHARACTERISTICS					
Output Capacitance (V _{CB} = 24 V _{dc} , I _E = 0, f = 1.0 MHz)	C _{ob}	—	7.5	10	pF
FUNCTIONAL TESTS					
Common-Base Amplifier Power Gain (V _{CC} = 24 V _{dc} , P _{out} = 5.0 W, f = 2.0 GHz)	G _{PB}	7.5	8.0	—	dB
Collector Efficiency (V _{CC} = 24 V _{dc} , P _{out} = 5.0 W, f = 2.0 GHz)	η	35	40	—	%
Load Mismatch (V _{CC} = 24 V _{dc} , P _{out} = 5.0 W, f = 2.0 GHz) VSWR = 10:1 All Phase Angles	ψ	No Degradation in Power Output			

FIGURE 1 — 2.0 GHz TEST CIRCUIT



- C1, C3, C4 — 68 pF Chip Capacitor
- C2 — 0.6-4.5 pF Johanson 7271
- C5 — 0.1 μF
- C6 — 10 μF, 35 V
- Z1-Z13 — Microstrip, See Photomaster, Figure 8.
- Bead — Ferroxcube 56-590-65/3B
- Board Material — 0.031" Teflon Fiberglass
ε_r = 2.5 ± 0.05

FIGURE 2 — OUTPUT POWER versus INPUT POWER
(f = 1.7 GHz)

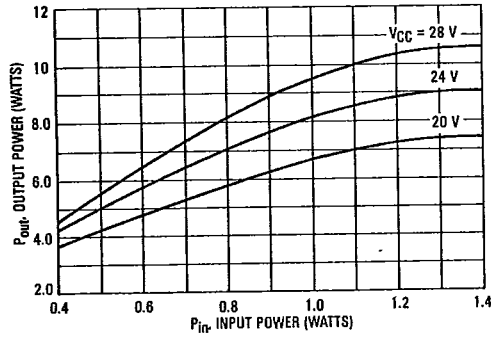


FIGURE 3 — OUTPUT POWER versus INPUT POWER
(f = 2.0 GHz)

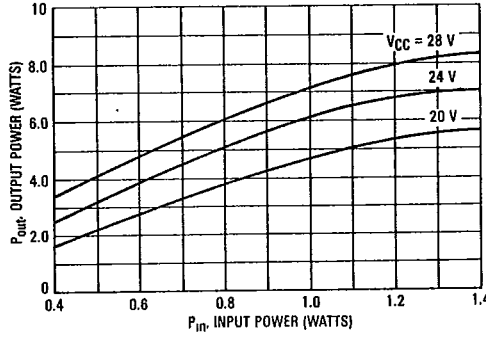


FIGURE 4 — OUTPUT POWER versus INPUT POWER
(f = 2.3 GHz)

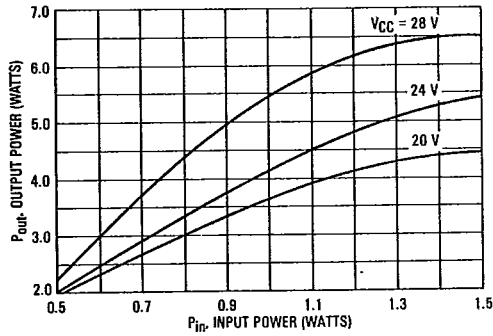


FIGURE 5 — POWER GAIN versus FREQUENCY

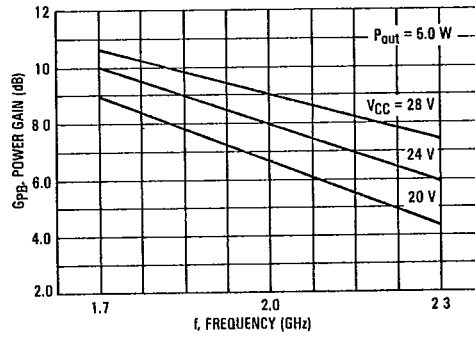
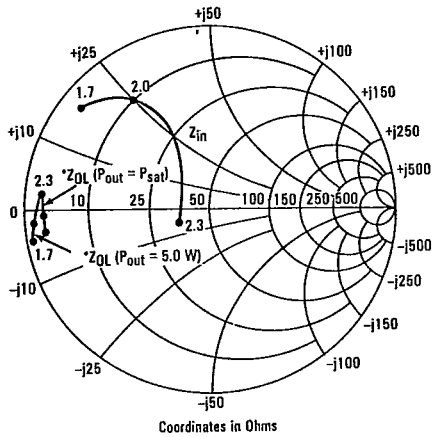


FIGURE 6 — SERIES EQUIVALENT INPUT/OUTPUT IMPEDANCE

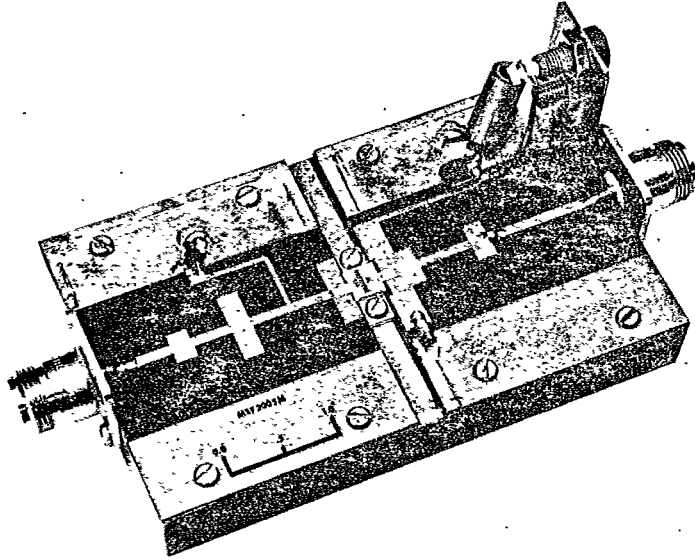


VCC = 24 V

f GHz	Z _{in} Ohms	Z _{OL} [*] , Ohms P _{out} = P _{sat}	Z _{OL} [*] , Ohms P _{out} = 5.0 W
1.7	4.0 + j17	2.9 - j3.5	1.5 - j4.4
2.0	10 + j25	3.1 - j0.85	1.75 - j1.3
2.3	37 - j5.0	2.9 + j2.2	2.90 + j2.2

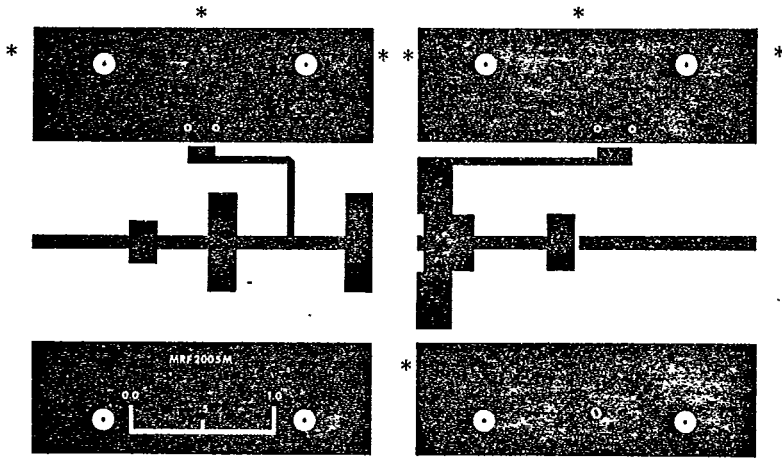
*Z_{OL} = Conjugate of the optimum load impedance into which the device output operates at a given output power, voltage, and frequency.

FIGURE 7 — 2 GHz TEST AMPLIFIER



2

FIGURE 8 — PRINTED CIRCUIT BOARD LAYOUT — 2.0 GHz TEST CIRCUIT



- ⊙ Denotes Eyelet
- ⊙ 4-40 Screw Placement
- * Foil Wrap to Bottom Ground Plane

NOTE: The Printed Circuit Board shown is 75% of the original.